

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/791,055	<b>Applicant(s)/Patent under Reexamination</b> BRICK ET AL.
	<b>Examiner</b> Leith A. Al-Nazer	<b>Art Unit</b> 2821

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
372	43.01	11/14/2005	LA
372	45.01	11/14/2005	LA
372	70, 75	11/14/2005	LA
385/129-132		11/14/2005	LA